

Notice of References Cited	Application/Control No. 10/710,551	Applicant(s)/Patent Under Reexamination OKUIE ET AL.	
	Examiner Huan H. Tran	Art Unit 2861	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,278,577	01-1994	Kitsuki, Kengo	347/214
*	B	US-5,719,616	02-1998	Danjo et al.	347/214
*	C	US-6,010,259	01-2000	Hadley, Keith A.	400/240.3
*	D	US-5,144,331	09-1992	Amano, Toshiaki	347/178
*	E	US-4,792,675	12-1988	Laughlin, Richard H.	250/227.28
*	F	US-4,805,985	02-1989	Fleck, Carl M.	385/12
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001-260447	09-2001	Japan	Ishikawa et al	B41J032/00
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.